# **Power MOSFET**

# 60 V, 24 m $\Omega$ , 26 A, Single N-Channel

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS5826NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These are Pb-Free Devices and RoHS Compliant

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage	9		V <sub>GS</sub>	±20	V
Continuous Drain Cur-	Steady State	T <sub>mb</sub> = 25°C	I <sub>D</sub>	26	Α
rent R $_{\Psi J-mb}$ (Notes 1, 2, 3, 4)		T <sub>mb</sub> = 100°C		19	
Power Dissipation		T <sub>mb</sub> = 25°C	$P_{D}$	39	W
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		T <sub>mb</sub> = 100°C		19	
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 3, 4)		T <sub>A</sub> = 25°C	I <sub>D</sub>	8.0	Α
	Steady State	T <sub>A</sub> = 100°C		6.0	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.6	W
R <sub>θJA</sub> (Notes 1 & 3)		T <sub>A</sub> = 100°C		1.8	
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	130	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			I <sub>S</sub>	32	Α
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 24 V, $V_{GS}$ = 10 V, $I_{L(pk)}$ = 20 A, L = 0.1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	3.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	42	

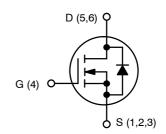
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



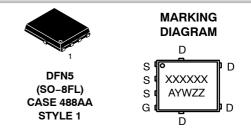
## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	24 mΩ @ 10 V	00.4
	32 mΩ @ 4.5 V	26 A



**N-CHANNEL MOSFET** 



A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

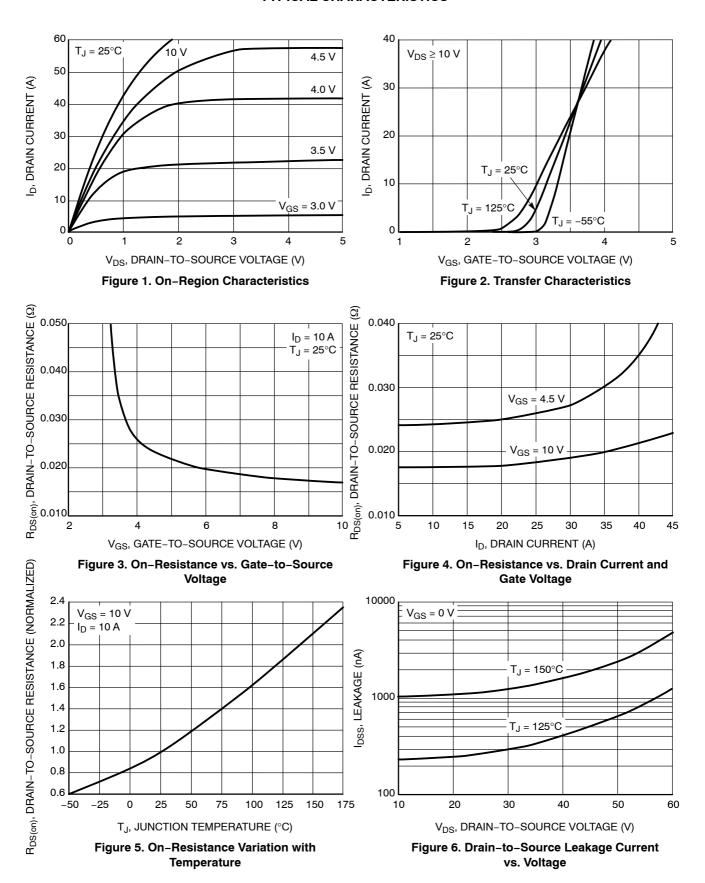
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

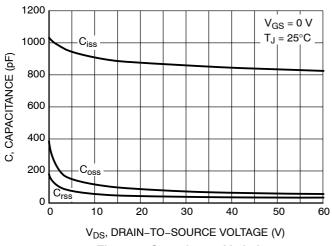
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			٧
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$				1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			10	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	<sub>S</sub> = ± 20 V			±100	nA
ON CHARACTERISTICS (Note 5)		_			-	•	•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.5		2.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>I</sub>	<sub>O</sub> = 10 A		18	24	mΩ
		V <sub>GS</sub> = 4.5 V, I	<sub>D</sub> = 10 A		24	32	1
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V,	I <sub>D</sub> = 5 A		8.0		S
CHARGES AND CAPACITANCES		_			-	•	•
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f =	1 MHz,		850		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 29$	ō V		85		1
Reverse Transfer Capacitance	C <sub>rss</sub>				50		1
Total Gate Charge	Q <sub>G(TOT)</sub>				9.1		
Threshold Gate Charge	Q <sub>G(TH)</sub>	1.,			1.0		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V}, I_{D} = 10 \text{ A}$			3.0		nC
Gate-to-Drain Charge	$Q_{GD}$				4.0		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 4	18 V, I <sub>D</sub> = 10 A		17		nC
SWITCHING CHARACTERISTICS (No	ote 6)	_			-	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>I</sub>	ns = 48 V.		32		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 10 \text{ A}, R_G = 2.5 \Omega$			15		ns
Fall Time	t <sub>f</sub>				24		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS	_			-	•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	1.2	V
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dls/dt = 100 A/ $\mu$ s, $I_{S}$ = 10 A			15		
Charge Time	ta				11		ns
Discharge Time	t <sub>b</sub>				4.0		
Reverse Recovery Charge	Q <sub>RR</sub>				11		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



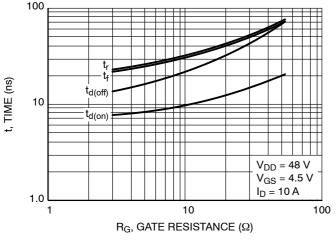
#### TYPICAL CHARACTERISTICS



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Q<sub>T</sub> 6 Qgd V<sub>DS</sub> = 48 A I<sub>D</sub> = 10 A  $T_{.l} = 25^{\circ}C$ 2 16 0 6 8 10 12 14 Qq, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total Charge



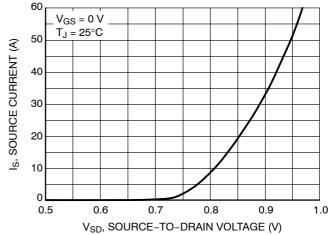
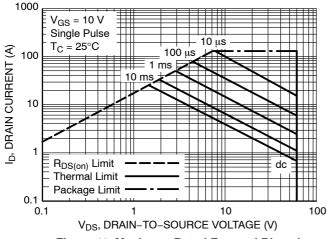


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



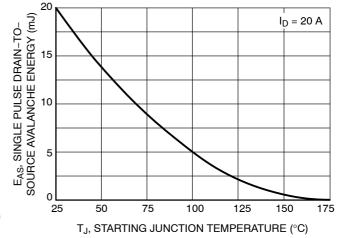


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**

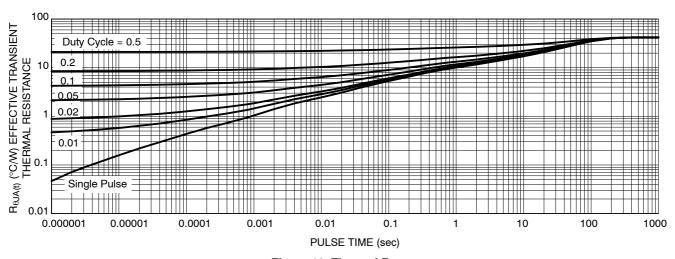


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package Shipping <sup>†</sup>		
NVMFS5826NLT1G	V5826L	DFN5 (Pb-Free)	1500 / Tape & Reel	
NVMFS5826NLWFT1G	5826LW	DFN5 (Pb-Free)	1500 / Tape & Reel	
NVMFS5826NLT3G	V5826L	DFN5 (Pb-Free)	5000 / Tape & Reel	
NVMFS5826NLWFT3G	5826LW	DFN5 (Pb-Free)	5000 / Tape & Reel	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

#### **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

### **GENERIC MARKING DIAGRAM\***

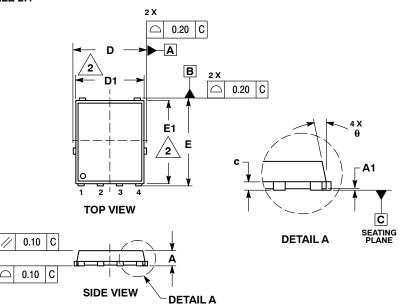


XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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